Search Notes

	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/699,163	MASHIYAMA ET AL.
	Examiner	Art Unit
_	Hae M. Hyeon	2839

	SEARCHED					
Class	Subclass	Date	Examiner			
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
439	608	2/05	howh		
439	108	1	V		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Update Search Done	2/05	- hmh	
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